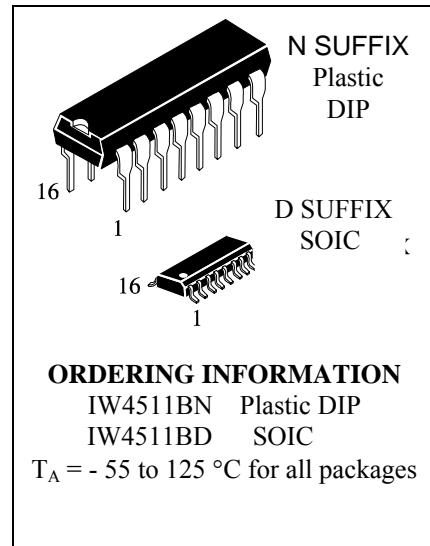


CMOS BCD-to-7-Segment Latch Decoder Drivers

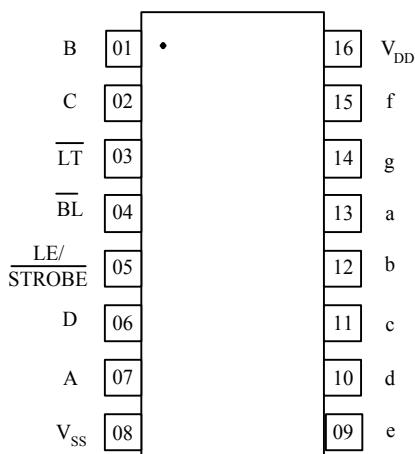
IW4511B

ICs IW4511B is used in high-performance computing systems with low power consumption in portable measuring equipments, communication devices with power supply from telephone networks, instruments using alternative power supplies (solar batteries, thermal elements) etc.

- Standard symmetrical output characteristic
- Operating Voltage Range: 3.0 to 18 V
- 100% testing for quiescent current at 20V
- Maximum input current of 1 μ A at 18 V over full package-temperature range; 100 nA at 18 V and 25°C
- Noise margin (over full package temperature range):
 - 1.0 V min @ 5.0 V supply
 - 2.0 V min @ 10.0 V supply
 - 2.5 V min @ 15.0 V supply



PIN ASSIGNMENT



TRUTH TABLE

Inputs							Outputs							Display
LE	BL	LT	D	C	B	A	a	b	c	d	e	f	g	
X	X	L	X	X	X	X	H	H	H	H	H	H	H	8
X	L	H	X	X	X	X	L	L	L	L	L	L	L	blank
L	H	H	L	L	L	L	H	H	H	H	H	H	L	0
L	H	H	L	L	L	H	L	H	H	L	L	L	L	1
L	H	H	L	L	H	L	H	H	L	H	L	L	H	2
L	H	H	L	L	H	H	H	H	H	H	L	L	H	3
L	H	H	L	H	L	L	L	H	H	L	L	H	H	4
L	H	H	L	H	L	H	H	L	H	H	L	H	H	5
L	H	H	L	H	H	L	L	L	H	H	H	H	H	6
L	H	H	L	H	H	H	H	H	H	L	L	L	L	7
L	H	H	H	L	L	L	H	H	H	H	H	H	H	8
L	H	H	H	L	L	H	H	H	L	L	H	H	H	9
L	H	H	H	L	H	L	L	L	L	L	L	L	L	blank
L	H	H	H	L	H	H	L	L	L	L	L	L	L	blank
L	H	H	H	H	L	L	L	L	L	L	L	L	L	blank
L	H	H	H	H	L	H	L	L	L	L	L	L	L	blank
L	H	H	H	H	H	L	L	L	L	L	L	L	L	blank
L	H	H	H	H	H	H	L	L	L	L	L	L	L	blank
H	H	H	X	X	X	X	*							*

* - Depends on BCD code previously applied when LE=L

X – Don't Care

MAXIMUM RATINGS

Symbol	Parameter	Recommended operating conditions		Maximum ratings		Unit
		min	max	min	max	
V _{DD}	DC Supply Voltage	3	18	-0.5	20	V
V _I	Input Voltage Range	-	-	-0.5	V _{DD} +0.5	V
V _O	Output Voltage Range	-	-	-0.5	V _{DD} +0.5	V
I _I	DC Input Current	-	-	-	±10	mA
P _D	Power dissipation per package	-	-	-	500*	mW
P _{tot}	Power Dissipation per Output Transistor	-	-	-	100	mW

*P_D for IW4511BN for temperature range -55 - +100 °C and for ICs IW4511BD for temperature range -55 - +65 °C
P_D for IW4511BN derate linearity at 12 mW/°C for temperature range +100 - +125°C.
P_D for IW4511BD derate linearity at 7 mW/°C for temperature range +65 - +125°C.

STATIC ELECTRICAL CHARACTERISTIC

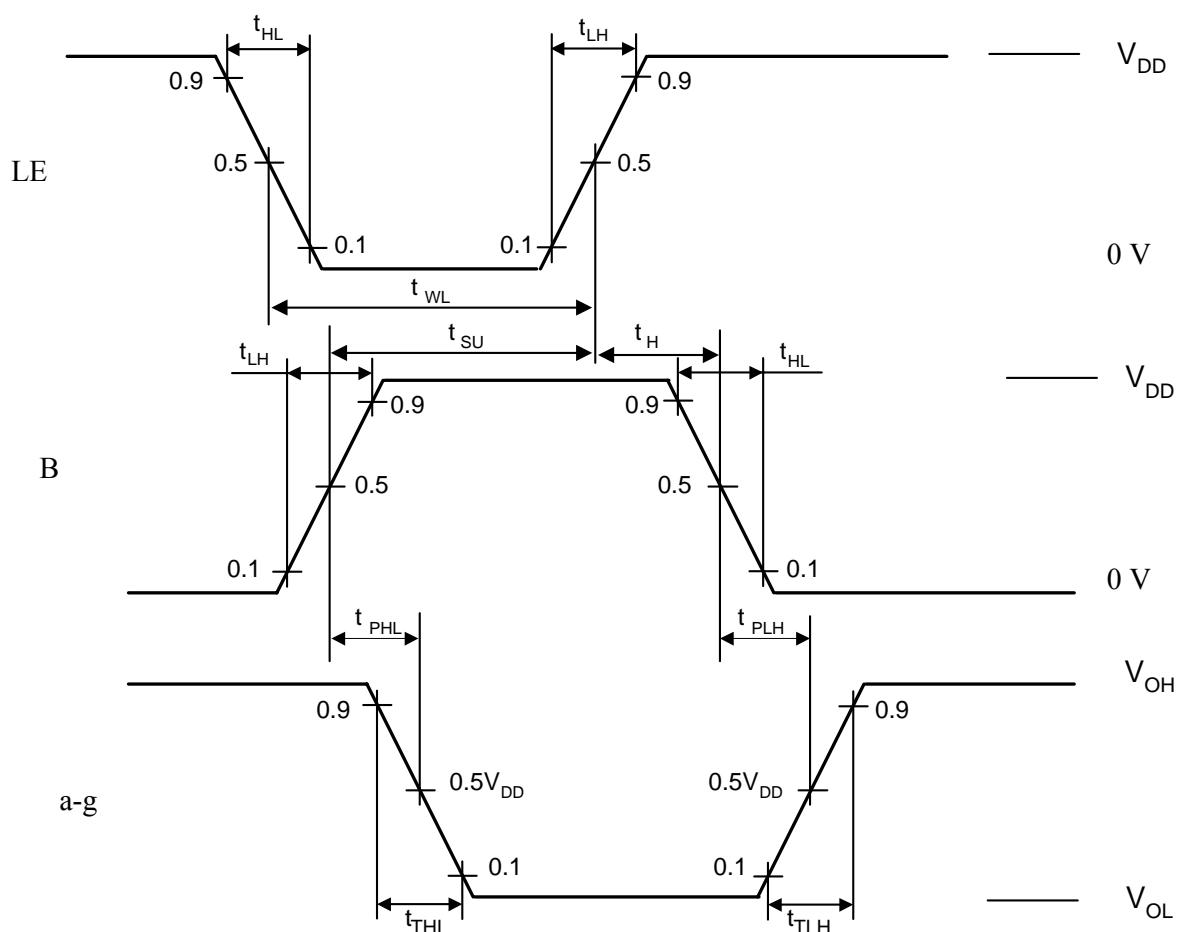
Symbol	Parameter	Test conditions	V_{DD} , V	Guaranteed Limits						Units	
				-55°C		25°C		125°C			
				min	max	min	max	min	max		
V_{IH}	Minimum High-Level Input Voltage	$V_O = 0.5 \text{ V or } V_{DD}-1.2 \text{ V}$	5.0	3.5	-	3.5	-	3.5	-	V	
		$V_O = 1.0 \text{ V or } V_{DD}-1.2 \text{ V}$	10	7.0	-	7.0	-	7.0	-		
		$V_O = 1.5 \text{ V or } V_{DD}-1.2 \text{ V}$	15	11	-	11	-	11	-		
V_{IL}	Maximum Low-Level Input Voltage	$V_O = 0.5 \text{ V or } V_{DD}-1.2 \text{ V}$	5.0	-	1.5	-	1.5	-	1.5	V	
		$V_O = 1.0 \text{ V or } V_{DD}-1.2 \text{ V}$	10	-	3.0	-	3.0	-	3.0		
		$V_O = 1.5 \text{ V or } V_{DD}-1.2 \text{ V}$	15	-	4.0	-	4.0	-	4.0		
V_{OH}	High-Level Output Voltage	$V_I = V_{SS} \text{ or } V_{DD}$	5.0	4.0	-	4.1	-	4.2	-	V	
			10	9.0	-	9.1	-	9.2	-		
			15	14.0	-	14.1	-	14.2	-		
V_{OL}	Low-Level Output Voltage	$V_I = V_{SS} \text{ or } V_{DD}$	5.0	-	0.05	-	0.05	-	0.05	V	
			10	-	0.05	-	0.05	-	0.05		
			15	-	0.05	-	0.05	-	0.05		
I_{IL}	Low -Level Input Current	$V_I = V_{SS}$	18	-	-0.1	-	-0.1	-	-1.0	μA	
I_{IH}	High -Level Input Current	$V_I = V_{DD}$	18	-	0.1	-	0.1	-	1.0	μA	
I_{DD}	Quiescent Devices Current	$V_I = V_{SS} \text{ or } V_{DD}$	5.0	-	5.0	-	5.0	-	150	μA	
			10	-	10	-	10	-	300		
			15	-	20	-	20	-	600		
			20	-	100	-	100	-	3000		
I_{OL}	Output Low (Sink) Current	$V_I = V_{SS} \text{ or } V_{DD}$	5.0	0.64	-	0.51	-	0.36	-	mA	
		$V_{OL} = 0.4 \text{ V}$	10	1.6	-	1.3	-	0.9	-		
		$V_{OL} = 0.5 \text{ V}$	15	4.2	-	3.4	-	2.4	-		
		$V_{OL} = 1.5 \text{ V}$									
I_{OH}	Output High (Source) Current	$V_I = V_{SS} \text{ or } V_{DD}$	5.0	-1.6	-	-1.3	-	-0.9	-	mA	
		$V_{OH} = 2.5 \text{ V}$	5.0	-0.46	-	-0.37	-	-0.26	-		
		$V_{OH} = 4.6 \text{ V}$	10	-0.98	-	-0.8	-	-0.55	-		
		$V_{OH} = 9.5 \text{ V}$	15	-3.33	-	-2.7	-	-1.9	-		
		$V_{OH} = 13.5 \text{ V}$									

DYNAMIC ELECTRICAL CHARACTERISTICS ($C_L=50\text{ pF}$, $R_L = 200\text{ kOhm}$, $t_{LH} = t_{HL} \leq 20\text{ ns}$)

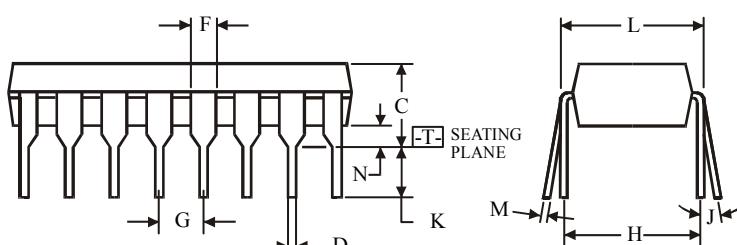
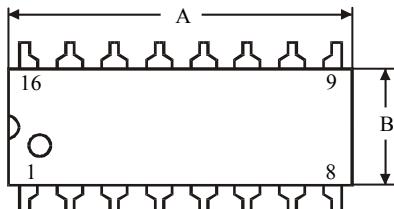
Symbol	Parameter	Test conditions	$V_{DD},$ V	Guaranteed Limits						Unit	
				-55 °C		25 °C		125 °C			
				min	max	min	max	min	max		
t_{PHL}	Propagation Delay Time High-to-Low Level Input (A-D)	Time diagram on the figure	5.0 10 15	- 420 300	1040 - -	- 420 300	1040 - -	- 840 600	2080	nc	
	Propagation Delay Time High-to-Low Level Input BL	Time diagram on the figure	5.0 10 15	- 350 250	700 - -	- 350 250	700 - -	- 700 500	1400		
	Propagation Delay Time High-to-Low Level Input LT	Time diagram on the figure	5.0 10 15	- 250 170	500 - -	- 250 170	500 - -	- 500 340	1000		
	Propagation Delay Time Low-to-High Level Input (A-D)	Time diagram on the figure	5.0 10 15	- 520 360	1320 - -	- 520 360	1320 - -	- 1040 720	2640	nc	
	Propagation Delay Time Low-to-High Level Input BL	Time diagram on the figure	5.0 10 15	- 350 300	800 - -	- 350 300	800 - -	- 700 600	1600		
	Propagation Delay Time Low-to-High Level Input LT	Time diagram on the figure	5.0 10 15	- 150 100	300 - -	- 150 100	300 - -	- 300 200	600		
t_{THL}	Transition Time High-to-Low Level	Time diagram on the figure	5.0 10 15	- 185 160	310 - -	- 185 160	310 - -	- 370 320	620	nc	
t_{TLH}	Transition Time Low-to-High Level	Time diagram on the figure	5.0 10 15	- 60 50	80 - -	- 60 50	80 - -	- 120 100	160	nc	
t_{SU}	Set-Up Time (A-D) as per LE	Time diagram on the figure	5.0 10 15	150 70 40	- - -	150 70 40	- - -	300 140 80	-	nc	
t_H	Hold Time (A - D) after LE	Time diagram on the figure	5.0 10 15	0 0 0	- - -	0 0 0	- - -	0 0 0	-	nc	
t_{WL}	LE Pulse Width	Time diagram on the figure	5.0 10 15	400 160 100	- - -	400 160 100	- - -	800 320 200	-	nc	

CAPACITANCE

Symbol	Parameter	V_{DD} , v	Guaranteed Limits		Unit
			min	max	
C_{IN}	Input Capacitance	-	-	7.5	pF



Time diagram when taking dynamic parameters

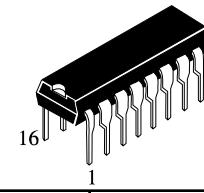
**N SUFFIX PLASTIC DIP
(MS - 001BB)**


$\oplus 0.25\text{ (0.010) } \ominus \text{ T}$

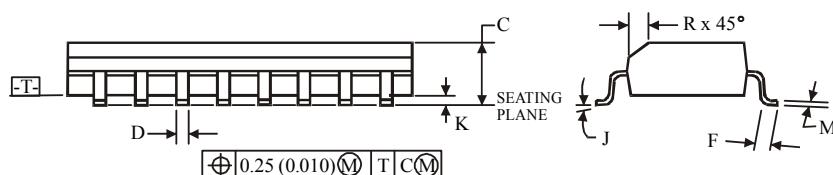
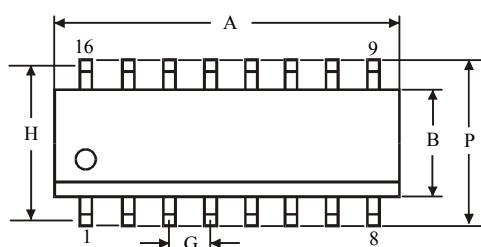
NOTES:

- Dimensions "A", "B" do not include mold flash or protrusions.

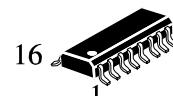
Maximum mold flash or protrusions 0.25 mm (0.010) per side.



Dimension, mm		
Symbol	MIN	MAX
A	18.67	19.69
B	6.1	7.11
C		5.33
D	0.36	0.56
F	1.14	1.78
G		2.54
H		7.62
J	0°	10°
K	2.92	3.81
L	7.62	8.26
M	0.2	0.36
N	0.38	

**D SUFFIX SOIC
(MS - 012AC)**

NOTES:

- Dimensions A and B do not include mold flash or protrusion.
- Maximum mold flash or protrusion 0.15 mm (0.006) per side for A; for B - 0.25 mm (0.010) per side.



Dimension, mm		
Symbol	MIN	MAX
A	9.8	10
B	3.8	4
C	1.35	1.75
D	0.33	0.51
F	0.4	1.27
G		1.27
H		5.72
J	0°	8°
K	0.1	0.25
M	0.19	0.25
P	5.8	6.2
R	0.25	0.5